



501.37854X00

*D. NOT enter
4/26/04
SL*

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE
EXPEDITED PROCEDURE PURSUANT
TO 37 CFR §1.116 REQUESTED
Attn: Mail Stop AF

Applicants: T. NAKATA, et al

Serial No.: 09/437,265

Filed: November 10, 1999

For: **METHOD FOR MEASURING DIMENSIONS AND ALIGNMENT OF THIN FILM MAGNETIC HEAD AND APPARATUS THEREFOR**

Group: 2877

Examiner: H. Lee

AMENDMENT AFTER FINAL

Attn: Mail Stop AF
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

April 19, 2004

Sir:

In response to the Office Action (Paper No. 1203) dated on December 19, 2003, please amend the above-identified application as follows. Applicants also request that an in-person Office Interview be scheduled and conducted as soon as possible to advance the prosecution of the application.

Amendments to the Specification begin on page 2 of this paper.

Amendments to the Claims begin on page 6 of this paper.

Remarks/Arguments begin on page 10 of this paper.